

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination UMEDA, AKIRA	
		Examiner Charles D. Garber	Art Unit 2856	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
U	PTO 06-349 English language translation of Umeda, Japanese Kokai Patent Application No. Hei 1[1992]-93653	
V	PTO 06-3084 English language translation of Umeda et al., "Frequency Characteristics of Accelerometers Measured by Impact in Low Frequencies".	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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